

Search Notes



Application/Control No.

10/500,080

Examiner

JOHN PAK

Applicant(s)/Patent under
Reexamination

FENG, WEIJIAN

Art Unit

1616

SEARCHED

| Class | Subclass | Date | Examiner |
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| 424 | 666 | 10/06 | JP |
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INTERFERENCE SEARCHED

| Class | Subclass | Date | Examiner |
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)

| | DATE | EXMR |
|---------------------------|-------|------|
| Inventor name searched | 10/06 | JP |
| WEST - see printout | 10/06 | JP |
| STN online - see printout | 10/06 | JP |
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